BAV756S; BAW56 series

High-speed switching diodes Rev. 6 — 18 March 2015

Product data sheet

1. Product profile

1.1 General description

High-speed switching diodes, encapsulated in small Surface-Mounted Device (SMD) plastic packages.

Table 1. Product overview

Type number	Package	_			Configuration
	NXP	JEITA	JEDEC	configuration	
BAV756S	SOT363	SC-88	-	very small	quadruple common anode/common cathode
BAW56	SOT23	-	TO-236AB	small	dual common anode
BAW56M	SOT883	SC-101	-	leadless ultra small	dual common anode
BAW56S	SOT363	SC-88	-	very small	quadruple common anode/common anode
BAW56T	SOT416	SC-75	-	ultra small	dual common anode
BAW56W	SOT323	SC-70	-	very small	dual common anode

1.2 Features and benefits

- High switching speed: t_{rr} ≤ 4 ns
- Low leakage current
- Small SMD plastic packages
- Low capacitance: C_d ≤ 2 pF
- Reverse voltage: V_R ≤ 90 V
- AEC-Q101 qualified

1.3 Applications

- High-speed switching
- General-purpose switching

1.4 Quick reference data

Table 2. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diode						
I _R	reverse current	V _R = 80 V	-	-	0.5	μΑ
V_R	reverse voltage		-	-	90	V
t _{rr}	reverse recovery time	[1]	-	-	4	ns

[1] When switched from $I_F = 10$ mA to $I_R = 10$ mA; $R_L = 100$ Ω ; measured at $I_R = 1$ mA.



2. Pinning information

Table 3. Pinning

Pin	Description	Simplified outline	Symbol
BAV756S	,		
1	anode (diode 1)		
2	cathode (diode 2)	H6 H5 H4	6 5 4
3	common anode (diode 2 and diode 3)	0	
4	cathode (diode 3)	1 2 3	
5	anode (diode 4)		1 2 3
6	common cathode (diode 1 and diode 4)		006aab103
BAW56; I	BAW56T; BAW56W		
1	cathode (diode 1)		
2	cathode (diode 2)	[3]	3
3	common anode	1 2 006aaa144	1 2 006aab099
BAW56M			
1	cathode (diode 1)		[3]
2	cathode (diode 2)	1 3	
3	common anode	2 Transparent top view	1 2 006aab099
BAW56S			
1	cathode (diode 1)	Do Do D	
2	cathode (diode 2)	H6 H5 H4	6 5 4
3	common anode (diode 3 and diode 4)	0	
4	cathode (diode 3)	1 2 3	Lo⊈ ⊈ │
5	cathode (diode 4)		1 2 3
6	common anode (diode 1 and diode 2)		006aab102

3. Ordering information

Table 4. Ordering information

Type number	Package					
	Name	Description	Version			
BAV756S	SC-88	plastic surface-mounted package; 6 leads	SOT363			
BAW56	-	plastic surface-mounted package; 3 leads	SOT23			
BAW56M	SC-101	leadless ultra small plastic package; 3 solder lands; body 1.0 \times 0.6 \times 0.5 mm	SOT883			
BAW56S	SC-88	plastic surface-mounted package; 6 leads	SOT363			
BAW56T	SC-75	plastic surface-mounted package; 3 leads	SOT416			
BAW56W	SC-70	plastic surface-mounted package; 3 leads	SOT323			

4. Marking

Table 5. Marking codes

3	
Type number	Marking code[1]
BAV756S	A7*
BAW56	A1*
BAW56M	S5
BAW56S	A1*
BAW56T	A1
BAW56W	A1*

^{[1] * = -:} made in Hong Kong

5. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit		
Per diode							
V _{RRM}	repetitive peak reverse voltage		-	90	V		
V_R	reverse voltage		-	90	V		
I _F	forward current						
	BAV756S	T _s = 60 °C	-	250	mA		
	BAW56	T _{amb} ≤ 25 °C	-	215	mA		
	BAW56M	T _{amb} ≤ 25 °C	-	150	mA		
	BAW56S	T _s = 60 °C	-	250	mA		
	BAW56T	T _s = 90 °C	-	150	mA		
	BAW56W	T _{amb} ≤ 25 °C	-	150	mA		

BAV756S_BAW56_SER

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^{* =} p: made in Hong Kong

^{* =} t: made in Malaysia

^{* =} W: made in China

Table 6. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
I _{FRM}	repetitive peak forward current		-	500	mA
I _{FSM}	non-repetitive peak forward	square wave [1]			
	current	t _p = 1 μs	-	4	Α
		t _p = 1 ms	-	1	Α
		t _p = 1 s	-	0.5	Α
P _{tot}	total power dissipation	[2]			
	BAV756S	T _s = 60 °C	-	350	mW
	BAW56	T _{amb} ≤ 25 °C	-	250	mW
	BAW56M	$T_{amb} \le 25 ^{\circ}C$ [3]	-	250	mW
	BAW56S	T _s = 60 °C	-	350	mW
	BAW56T	T _s = 90 °C [4]	-	170	mW
	BAW56W	T _{amb} ≤ 25 °C	-	200	mW
Per device	•				•
I _F	forward current				
	BAV756S	T _s = 60 °C	-	100	mA
	BAW56	T _{amb} ≤ 25 °C	-	125	mA
	BAW56M	T _{amb} ≤ 25 °C	-	75	mA
	BAW56S	T _s = 60 °C	-	100	mA
	BAW56T	T _s = 90 °C	-	75	mA
	BAW56W	T _{amb} ≤ 25 °C	-	130	mA
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

^[1] $T_j = 25$ °C prior to surge.

6. Thermal characteristics

Table 7. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
Per diode	Per diode						
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air [1]					
	BAW56		-	-	500	K/W	
	BAW56M	[2]	-	-	500	K/W	
	BAW56W		-	-	625	K/W	

^[2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint

^[3] Reflow soldering is the only recommended soldering method.

^[4] Single diode loaded.

Table 7. Thermal characteristics ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-sp)}	thermal resistance from junction to solder point					
	BAV756S		-	-	255	K/W
	BAW56		-	-	360	K/W
	BAW56S		-	-	255	K/W
	BAW56T		-	-	350	K/W
	BAW56W		-	-	300	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Reflow soldering is the only recommended soldering method.

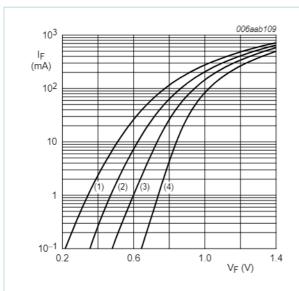
7. Characteristics

Table 8. Characteristics

 T_{amb} = 25 °C unless otherwise specified.

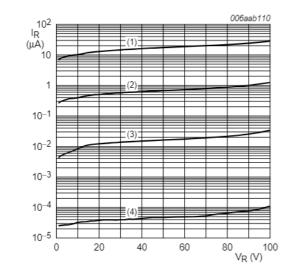
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diode						
V_{F}	forward voltage	[1]				
		I _F = 1 mA	-	-	715	mV
		I _F = 10 mA	-	-	855	mV
		I _F = 50 mA	-	-	1	V
		I _F = 150 mA	-	-	1.25	V
I _R	reverse current	V _R = 25 V	-	-	30	nA
		V _R = 80 V	-	-	0.5	μА
		V _R = 25 V; T _j = 150 °C	-	-	30	μА
		V _R = 80 V; T _j = 150 °C	-	-	150	μА
C _d	diode capacitance	$V_R = 0 V$; $f = 1 MHz$	-	-	2	pF
t _{rr}	reverse recovery time	[2]	-	-	4	ns
V_{FR}	forward recovery voltage	[3]	-	-	1.75	V

- [1] Pulse test: $t_p \le 300 \ \mu s$; $\delta \le 0.02$.
- [2] When switched from I_F = 10 mA to I_R = 10 mA; R_L = 100 Ω ; measured at I_R = 1 mA.
- [3] When switched from I_F = 10 mA; t_r = 20 ns.



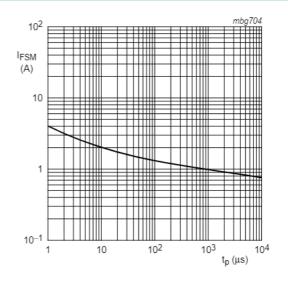
- (1) T_{amb} = 150 °C
- (2) T_{amb} = 85 °C
- (3) $T_{amb} = 25 \, ^{\circ}C$
- (4) $T_{amb} = -40 \, ^{\circ}C$

Fig 1. Forward current as a function of forward voltage; typical values



- (1) T_{amb} = 150 °C
- (2) T_{amb} = 85 °C
- (3) $T_{amb} = 25 \, ^{\circ}C$
- (4) $T_{amb} = -40 \, ^{\circ}C$

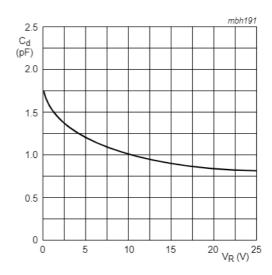
Fig 3. Reverse current as a function of reverse voltage; typical values



Based on square wave currents.

T_i = 25 °C; prior to surge

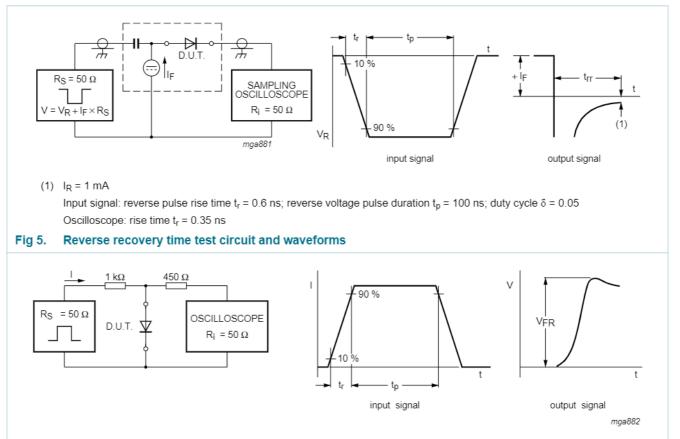
Fig 2. Non-repetitive peak forward current as a function of pulse duration; maximum values



f = 1 MHz; T_{amb} = 25 °C

Fig 4. Diode capacitance as a function of reverse voltage; typical values

8. Test information



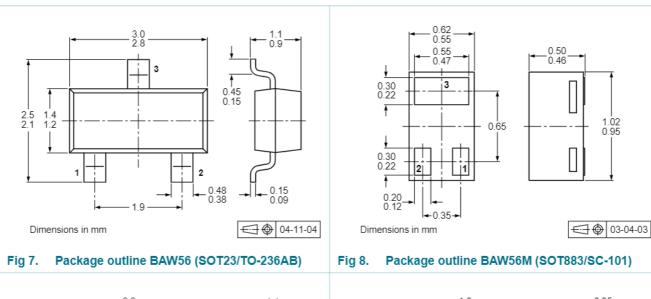
Input signal: forward pulse rise time $t_r = 20$ ns; forward current pulse duration $t_p \ge 100$ ns; duty cycle $\delta \le 0.005$

Fig 6. Forward recovery voltage test circuit and waveforms

8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

Package outline



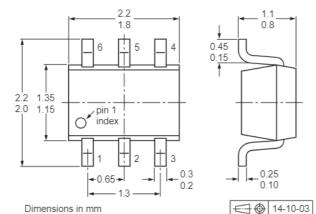


Fig 9. Package outline BAV756S and BAW56S (SOT363/SC-88)

Dimensions in mm

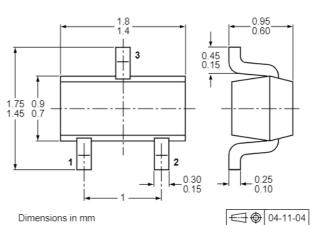


Fig 10. Package outline BAW56T (SOT416/SC-75)

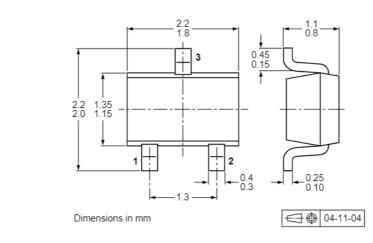


Fig 11. Package outline BAW56W (SOT323/SC-70)

BAV756S_BAW56_SER

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10. Packing information

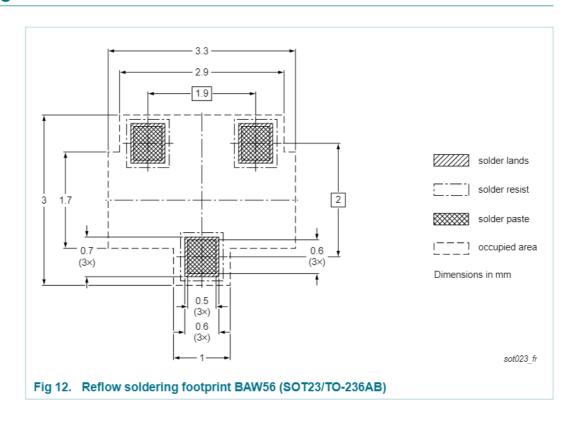
Table 9. Packing methods

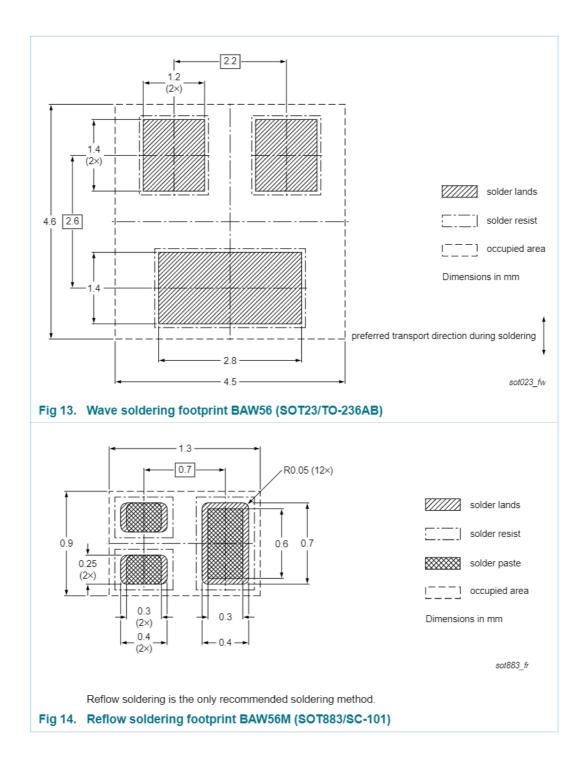
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

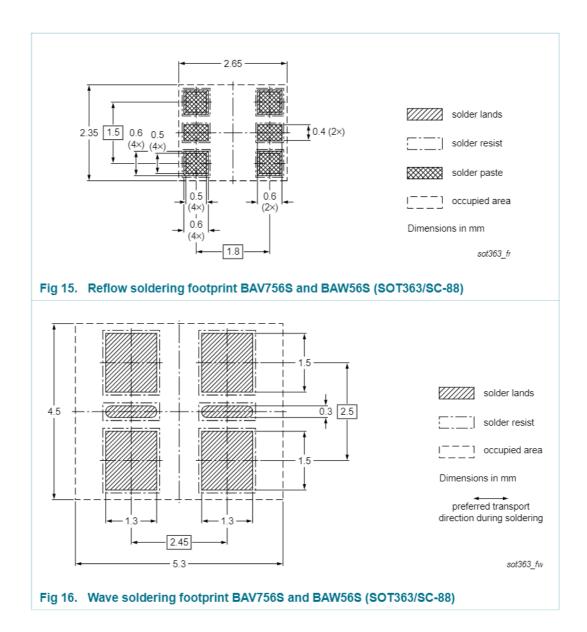
Type number	Package	Description	Packing quantity		
			3000	10000	
BAV756S	SOT363	4 mm pitch, 8 mm tape and reel; T1	-115	-135	
		4 mm pitch, 8 mm tape and reel; T2	-125	-165	
BAW56	SOT23	4 mm pitch, 8 mm tape and reel	-215	-235	
BAW56M	SOT883	2 mm pitch, 8 mm tape and reel	-	-315	
BAW56S	SOT363	4 mm pitch, 8 mm tape and reel; T1	-115	-135	
		4 mm pitch, 8 mm tape and reel; T2	-125	-165	
BAW56T	SOT416	4 mm pitch, 8 mm tape and reel	-115	-135	
BAW56W	SOT323	4 mm pitch, 8 mm tape and reel	-115	-135	

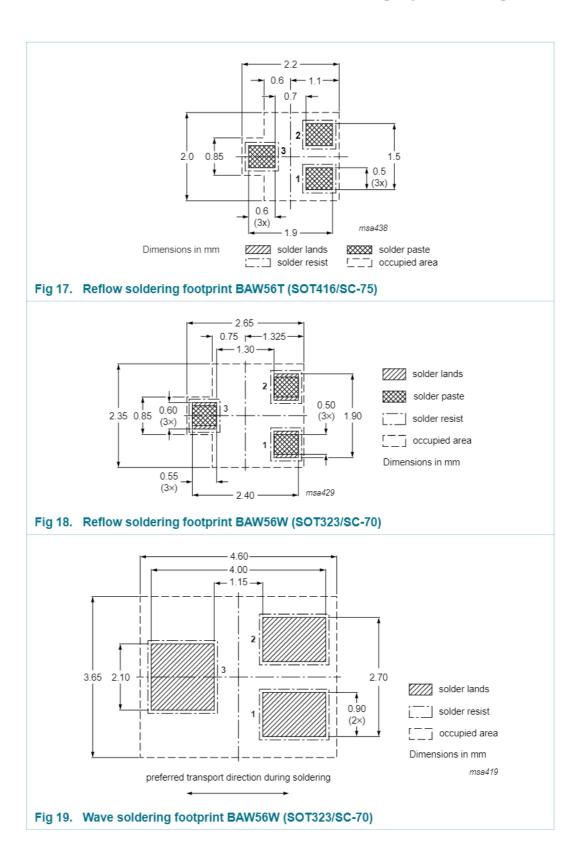
- [1] For further information and the availability of packing methods, see Section 14.
- [2] T1: normal taping
- [3] T2: reverse taping

11. Soldering









12. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
BAV756S_BAW56_SER v.6	20150318	Product data sheet	-	BAV756S_BAW56_SER_ 5		
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. 					
	 Legal texts ha 	ave been adapted to the new	company name whe	re appropriate.		
BAV756S_BAW56_SER_5	20071126	Product data sheet	-	BAV756S_2 BAW56_4 BAW56S_2 BAW56T_2 BAW56W_4		
BAV756S_2	19971021	Product specification	-	BAV756S_1		
BAW56_4	20030325	Product specification	-	BAW56_3		
BAW56S_2	19971021	Product specification	-	BAW56S_1		
BAW56T_2	19971219	Product specification	-	-		
BAW56W_4	19990511	Product specification	-	BAW56W_3		

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13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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High-speed switching diodes

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BAV756S; BAW56 series

High-speed switching diodes

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